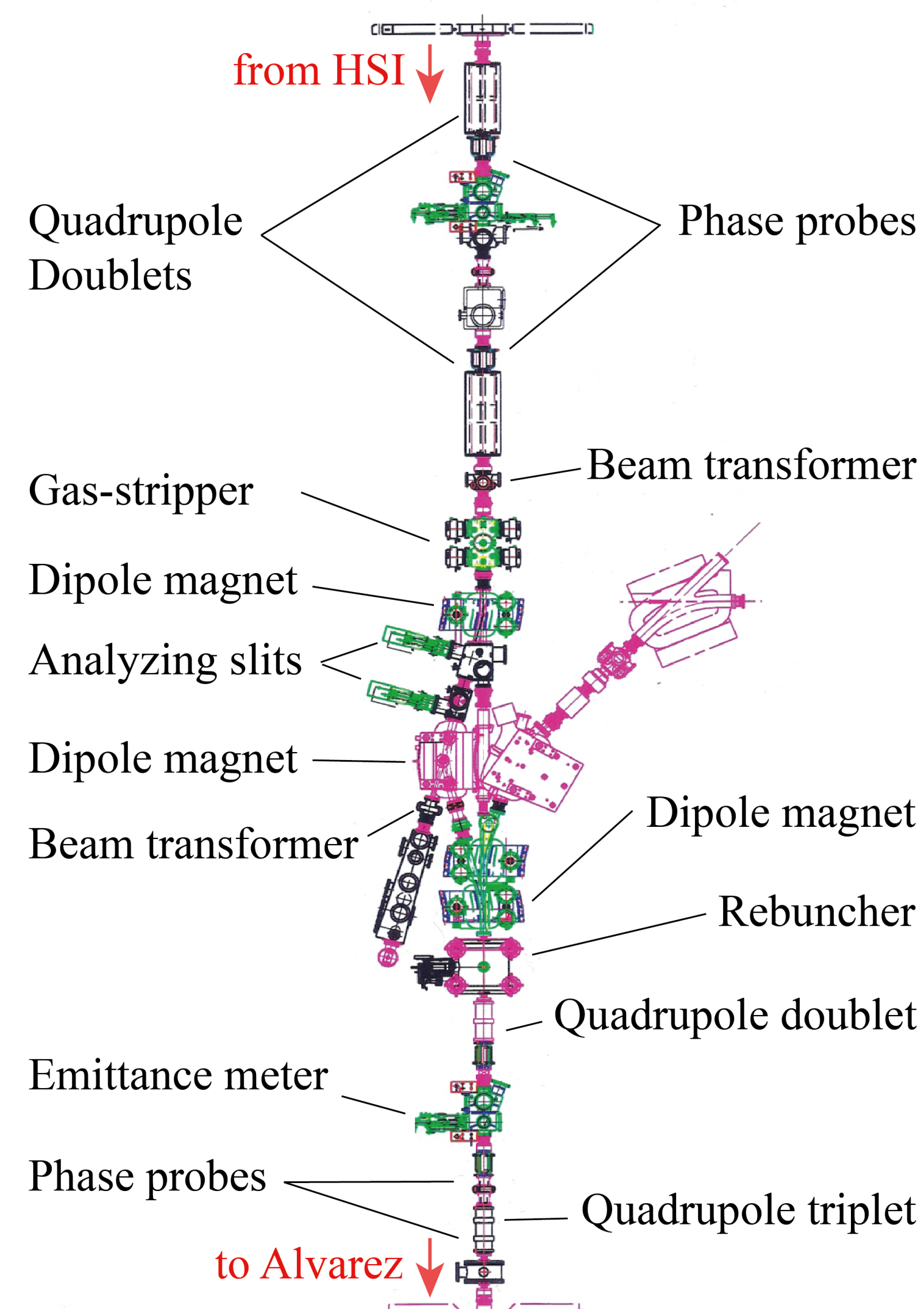


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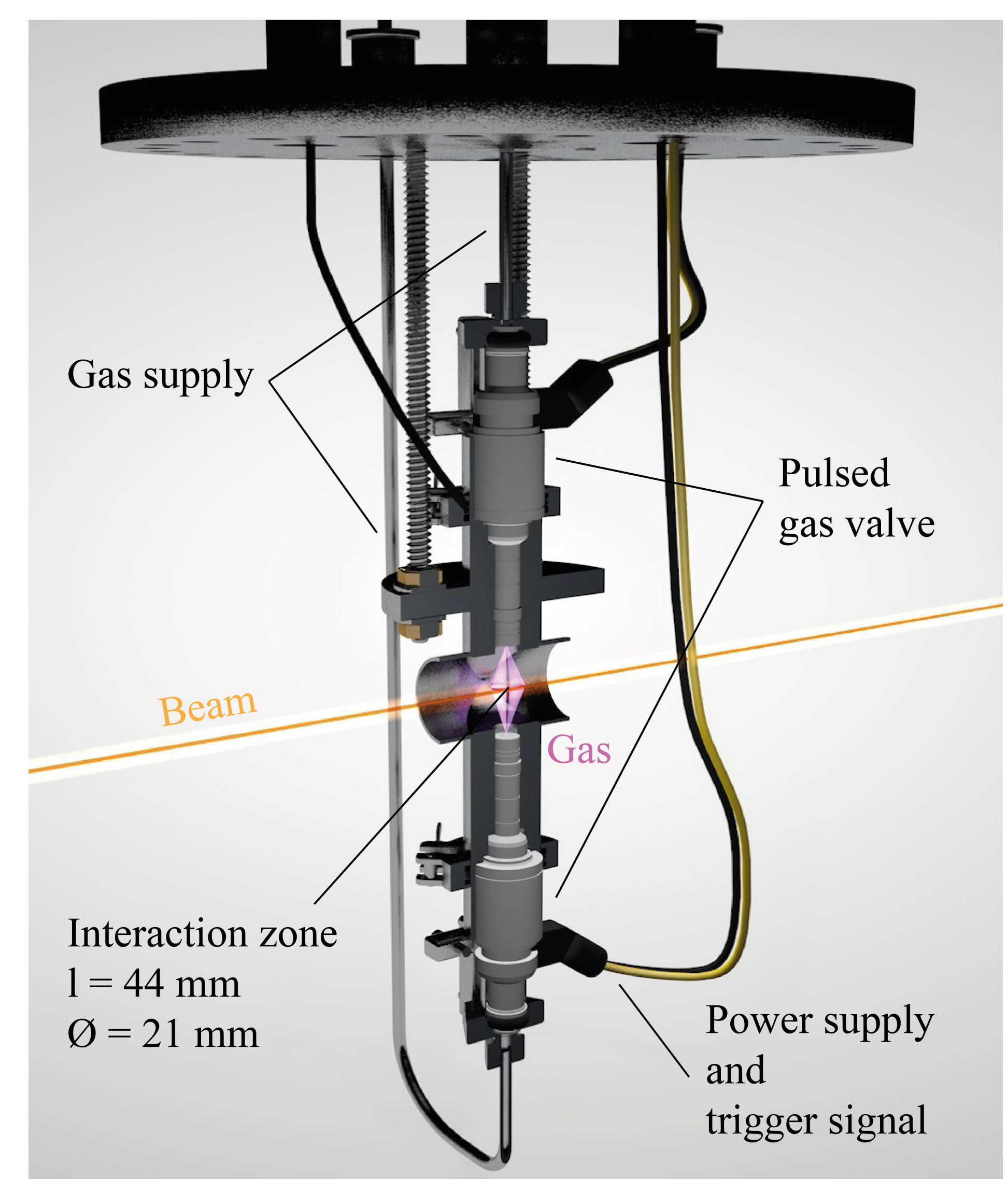
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## Abstract

- GSI UNILAC will serve as injector for FAIR
- Pulsed gas stripper setup was developed in the course of upgrade program for the UNILAC
- Pulsed gas injection enables practical use of H<sub>2</sub> and He
- Increased <sup>238</sup>U<sup>28+</sup> intensities were measured using H<sub>2</sub>
- For standard operation at the UNILAC, various different ion beams are used
- Stripping performance of the pulsed gas cell was tested using <sup>238</sup>U, <sup>209</sup>Bi, <sup>50</sup>Ti, and <sup>40</sup>Ar beams on H<sub>2</sub>, He, and N<sub>2</sub>
- Saturated charge state distributions were measured for all ion beams and compared to measurements with the previously existing N<sub>2</sub>-jet gas stripper
- Use of H<sub>2</sub> enabled increased average charge states for all utilized ion beams
- More narrow charge state distributions were measured for <sup>238</sup>U and <sup>209</sup>Bi, allowing for increased beam intensities

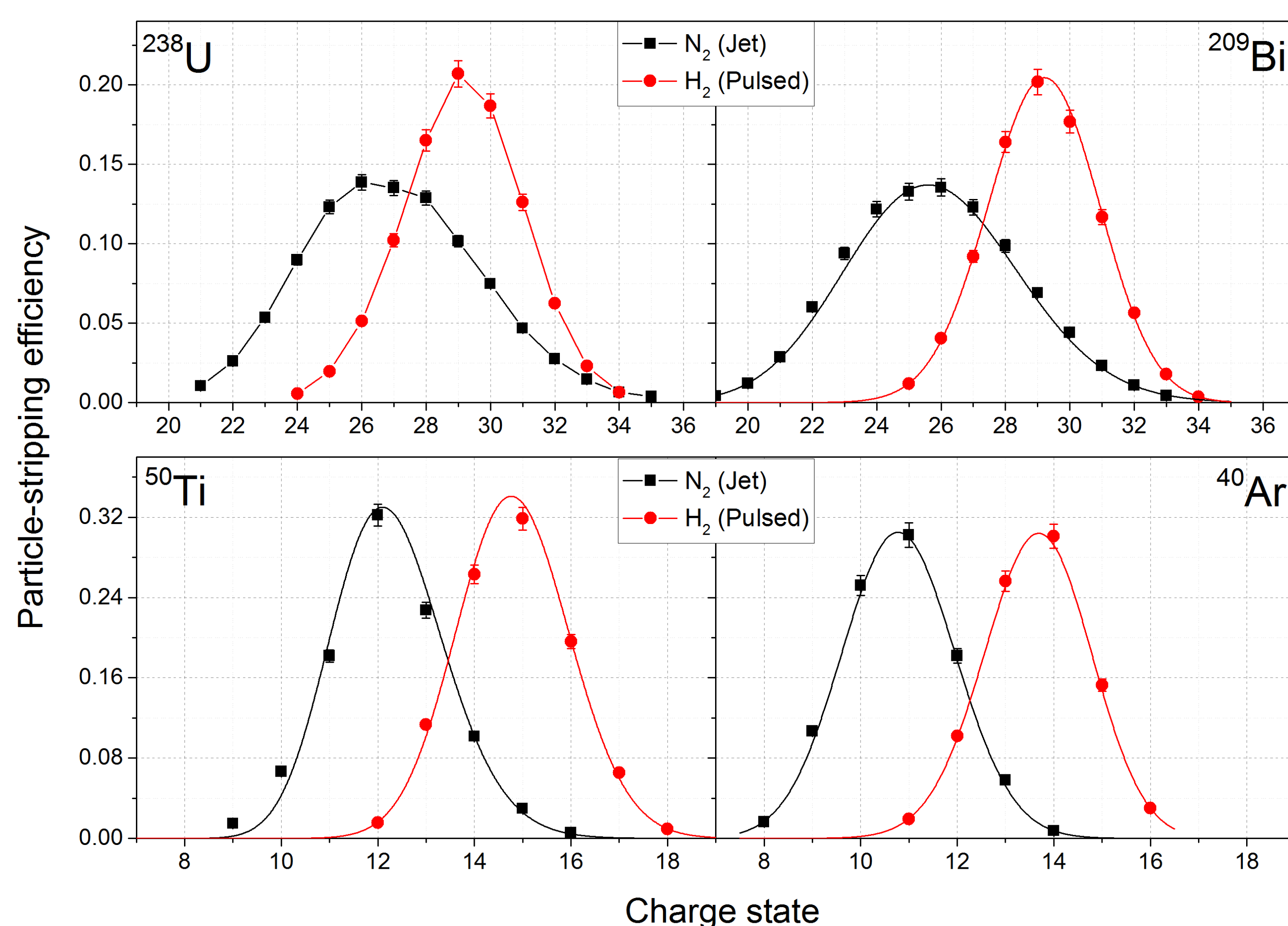


GSI UNILAC gas stripper section



Setup of the top flange of the pulsed gas stripper

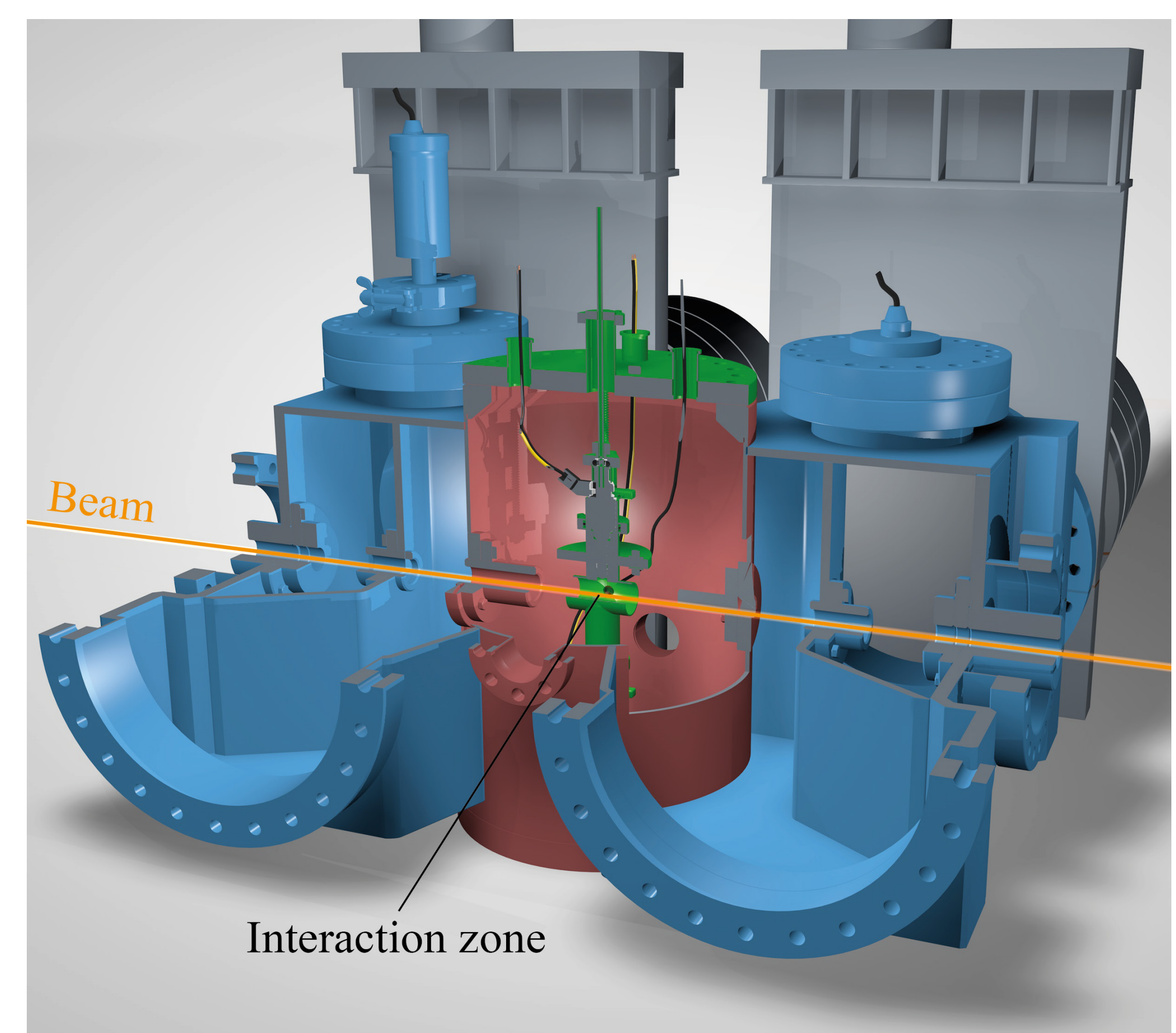
## Results



Saturated charge state distributions for <sup>238</sup>U, <sup>209</sup>Bi, <sup>50</sup>Ti, and <sup>40</sup>Ar ion beams after passing the N<sub>2</sub>-jet gas stripper (black) and the pulsed H<sub>2</sub>-gas stripper (red). Corresponding target thicknesses are listed below.

Ion	Stripper	$X$ [ $\mu\text{m}/\text{cm}^2$ ]	$dE$ [keV/u (%)]	$q_{\text{max}}$	$\eta_{\text{max}}$ [%]	$\epsilon_x$ (tot., norm., 90 %) [mm-mrad]	$\epsilon_y$ (tot., norm., 90 %) [mm-mrad]
<sup>238</sup> U	N <sub>2</sub> (Jet)	8	14 ± 5 (1)	26.6	13.9 ± 0.5	0.76 (at 3.7 mA, 28+)	0.84
	H <sub>2</sub> (Pulsed)	21	40 ± 5 (2.9)	29.2	21.0 ± 0.8	0.56 (at 6.1 mA, 29+)	1.07
<sup>209</sup> Bi	N <sub>2</sub> (Jet)	8	-	25.5	13.9 ± 0.6	0.61 (at 1.8 mA, 26+)	0.72
	H <sub>2</sub> (Pulsed)	37	80 ± 5 (6.4)	29.1	20.2 ± 0.8	0.82 (at 2.8 mA, 29+)	0.82
<sup>50</sup> Ti	N <sub>2</sub> (Jet)	7	-	12.1	32.2 ± 1.3	-	-
	H <sub>2</sub> (Pulsed)	32	76 ± 5 (5.4)	14.8	31.9 ± 1.3	-	-
<sup>40</sup> Ar	N <sub>2</sub> (Jet)	6	-	10.8	29.6 ± 1.2	0.39 (at 102 $\mu\text{A}$ , 11+)	0.42
	H <sub>2</sub> (Pulsed)	37	100 ± 5 (7.1)	13.7	30.1 ± 1.2	0.83 (at 126 $\mu\text{A}$ , 14+)	0.72

Comparison of the estimated target thickness  $X$ , energy loss  $dE$ , average charge state  $q_{\text{max}}$ , maximum stripping efficiency  $\eta_{\text{max}}$ , and horizontal and vertical beam emittance,  $\epsilon_x$  and  $\epsilon_y$  (corresponding beam current and ion charge state shown in brackets) of the N<sub>2</sub>-jet gas stripper and the pulsed H<sub>2</sub>-gas stripper.



Main parts of the gas stripper: The stripper flange (green) is located on top of the main stripper chamber (red). The windowless gas target is enabled by a four-stage differential pumping system (partly shown in blue).

## Conclusion

- Saturated charge state distributions were measured for <sup>238</sup>U, <sup>209</sup>Bi, <sup>50</sup>Ti, and <sup>40</sup>Ar ion beams on H<sub>2</sub>, He, and N<sub>2</sub>
- Increased average charge states were measured for all ion beam types by using the pulsed H<sub>2</sub> target
- This allows use of higher charge states without loss of efficiency, enabling a reduced power consumption of adjacent accelerator structures
- For <sup>238</sup>U and <sup>209</sup>Bi ion beams, a more narrow charge state distribution was observed
- This enables significantly increased beam intensities for beam ions with the populated charge states
- In general, the increased applied target thickness results in increased energy loss and beam emittance